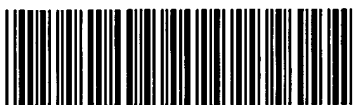


Search Notes

Application/Control No.

10/619,814

Examiner

Sung H. Pak

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	31,33,36, 37, 38	2/28/2005	SP
398	147-150	2/28/2005	SP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search: USPAT; USPGPUB; EPO;JPO; DERWENT; IBM see text search notes	2/28/2005	SP